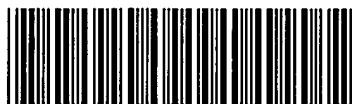


Search Notes

Application/Control No.

09/529,665

Examiner

Thomas D. Lee

Applicant(s)/Patent under
Reexamination

NAKABAYASHI ET AL.

Art Unit

2624

SEARCHED

Class	Subclass	Date	Examiner
358	1.1, 1.2, 1.9, 2.1, 443, 444	9/29/2003	TDL
358	448	9/29/2003	TDL
updated		7/6/2005	TDL
updated		1/19/2006	TDL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner